

WSF4022

Dual N-Ch MOSFET

General Description

The WSF4022 is the highest performance trench Dual N-Ch MOSFET with extreme high cell density,which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The WSF4022 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

Features

Advanced high cell density Trench technology Super Low Gate Charge Excellent CdV/dt effect decline 100% EAS Guaranteed Green Device Available

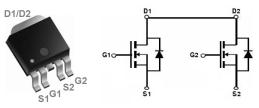
Product Summery

Bvdss	Rdson	lо
40V	21m Ω	20A

Applications

For Fan Pre-driver H-Bridge. Motor Control. Synchronous Rectification.

TO-252-4L Pin Configuration



Absolute Maximum Ratings @TA=25°C unless otherwise noted

Symbol	Parameter	Rating	Units	
V _{DS}	Drain-Source Voltage	40	V	
V_{GS}	Gate-Source Voltage		±20	V
I _D	Drain Current (Continuous) *AC	T _C =25°C	20*	A
I _D	Drain Current (Continuous) *AC	T _C =100°C	20*	A
I _D	Drain Current (Continuous) *AC	T _A =25°C	12.2	A
I _D	Drain Current (Continuous) *AC	T _A =70°C	10.2	A
ا _{DM} ^a	Pulsed Drain Current	T _C =25°C	80*	A
E _{AS} ^b	Single Pulse Avalanche Energy	L=0.5mH	25	mJ
I _{AS} ^b	Avalanche Current	L=0.5mH	17.8	A
P _D	Maximum Power Dissipation	T _C =25°C	39.4	W
P _D	Maximum Power Dissipation	T _C =100°C	19.7	W
P _D	Power Dissipation	T _A =25°C	6.4	W
P _D	Power Dissipation	T _A =70°C	4.2	W
TJ	Operating Junction Temperature Range		175	°C
T _{STG}	Operating Temperature/ Storage Temperature		-55~175	C°
R _{eja} ^b	Thermal Resistance Junction-Ambient	Steady State ^c	60	°C/W
R _{eJC}	Thermal Resistance Junction to Case		3.8	°C/W

Note *: Limited by package.

Note a: Pulse width limited by max. junction temperature.

Note b: UIS tested and pulse width limited by maximum junction temperature 175°C (initial temperature Tj=25°C).

Note c: Surface Mounted on 1in2 pad area, t =999sec.



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Electrical Characteristics @T_A=25 $^\circ\!\!\mathbb{C}$ unless otherwise noted

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Static	·	·				
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250µA	40			V
ldss	Zero Gate Voltage Drain Current	V _{DS} = 32V, V _{GS} = 0V			1	μA
ldss	Zero Gate Voltage Drain Current	$V_{DS} = 32V, V_{GS} = 0V, T_{J} = 85^{\circ}C$			30	μA
lgss	Gate Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{GS} = V _{DS} , I _{DS} = 250µA	1.1	1.6	2.5	V
R _{DS(on)} ^d		V _{GS} = 10V, I _D = 10A		16	21	mΩ
	Drain-Source On-state Resistance	V _{GS} = 4.5V, I _D = 5A		18	25	mΩ
Gate Charge	e	·				
Qg	Total Gate Charge			7.5		nC
Qgs	Gate-Source Charge	V _{DS} =20V,V _{GS} =4.5V, I _D =10A		3.24		nC
Qgd	Gate-Drain Charge			2.75		nC
Dynamic ^e		•	-	•		
Ciss	Input Capacitance			815		pF
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =20V, f=1MHz		95		pF
Crss	Reverse Transfer Capacitance			60		pF
td (on)	Turn-on Delay Time			7.8		ns
tr	Turn-on Rise Time	V _{DD} =20V, V _{GEN} =10V,		6.9		ns
td(off)	Turn-off Delay Time	$I_{DS}=1A,R_G=6\Omega,R_L=20\Omega.$		22.4		ns
tf	Turn-off Fall Time			4.8		ns
Diode	·					
V _{SD} ^d	Diode Forward Voltage	I _{SD} =1A, V _{GS} =0V		0.75	1.1	V
trr	Input Capacitance	L =100 dL /dt=1000/up		13		ns
Qrr	Output Capacitance	I _{DS} =10A, dl _{SD} /dt=100A/μs		8.7		nC

Note d: Pulse test ; pulse width \leq 300µs, duty cycle \leq 2%.

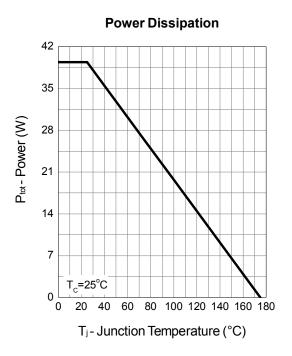
Note e: Guaranteed by design, not subject to production testing.



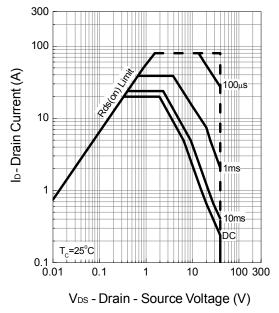
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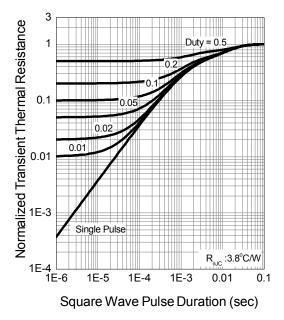
Typical Characteristics



Safe Operation Area



Thermal Transient Impedance

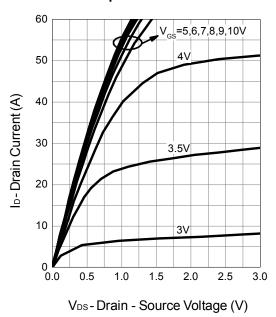


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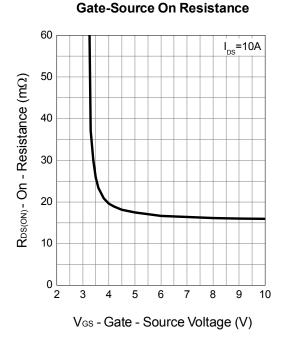
Typical Characteristics



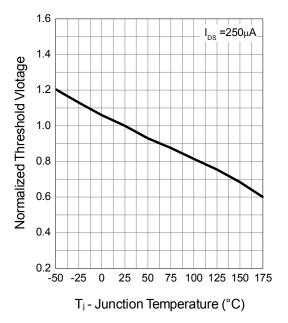
Output Characteristics

35 30 R_{DS(ON)} - On - Resistance (mΩ) 25 20 V_{GS}=4.5V V_{GS}=10V 15 10 5 L 0 10 20 30 40 50 60 ID-Drain Current (A)

Drain-Source On Resistance



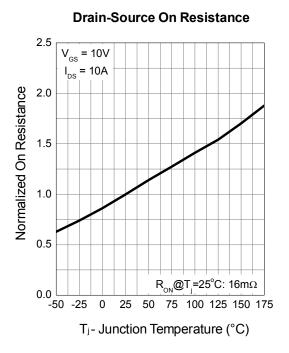
Gate Threshold Voltage





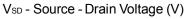
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Typical Characteristics



 $\begin{array}{c} 80 \\ 10 \\ 10 \\ 10 \\ 1 \\ 1 \\ 0.1 \\ 0.0 \\ 0.3 \\ 0.6 \\ 0.9 \\ 1.2 \\ 1.5 \end{array}$

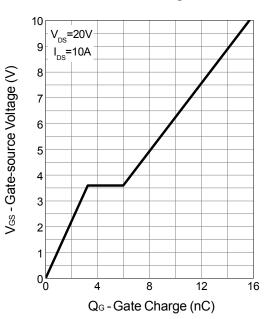
Source-Drain Diode Forward



1200 Frequency=1MHz 1000 Ciss C - Capacitance (pF) 800 600 400 200 Coss Crss 0 L 0 16 40 8 24 32 VDS - Drain - Source Voltage (V)

Capacitance

Gate Charge

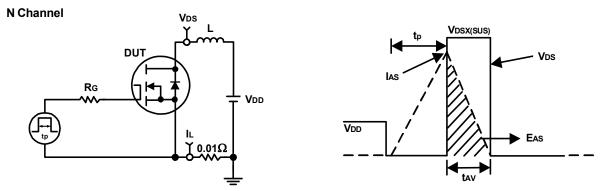




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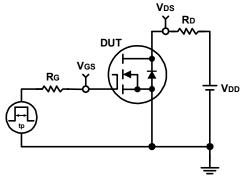
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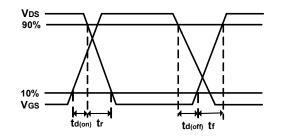
Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms

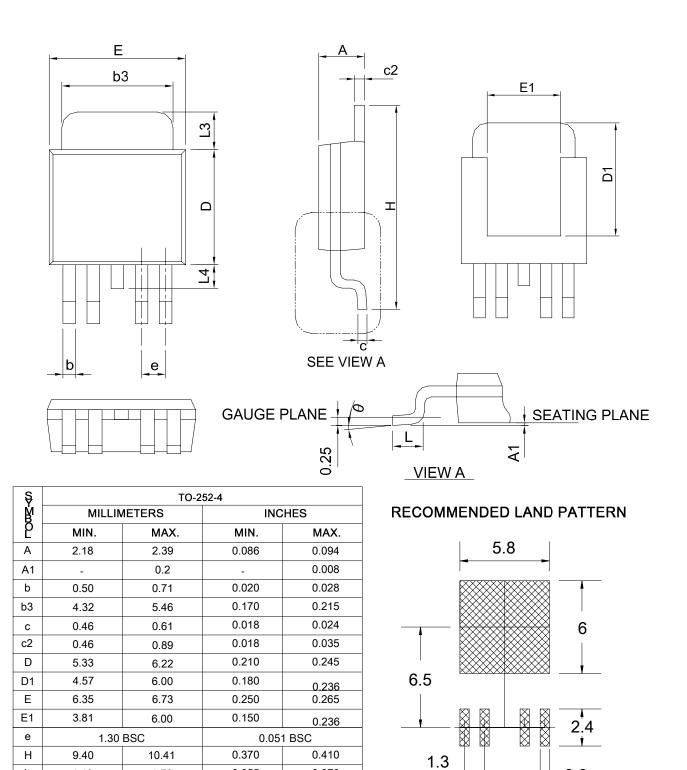
N Channel







TO-252-4



0.055

0.035

-

0°

0.070

0.080

0.040

8°

L

L3

L4

θ

1.40

0.89

_

0°

1.78

2.03

1.02

8°

0.6

UNIT: mm



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